
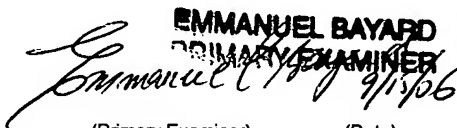



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/691,133	CHEN ET AL.	
	Examiner	Art Unit	
	Emmanuel Bayard	2611	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375	229								
INTERNATIONAL CLASSIFICATION									
A03H	7130								
			/						
			/						
			/						
			/						

(Assistant Examiner) (Date)		EMMANUEL BAYARD  PRIMARY EXAMINER (Primary Examiner) (Date)	Total Claims Allowed: 33	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 21

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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